

Search Notes

Application/Control No.

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Examiner

John Q. Nguyen

Applicant(s)/Patent under
Reexamination

ISHIHARA ET AL.

Art Unit

3654

SEARCHED

Class	Subclass	Date	Examiner
Previous	search updated	2/14/06	JN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR